Silicon isotope separation in a SiF₄ molecular jet by two-frequency IR multiphoton dissociation

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Abstract Silicon isotope separation has been performed by infrared multiphoton dissociation of pure SiF₄ molecular jet, using two TEA CO₂ laser. The dissociation process was monitored with a Time-of-Flight mass spectrometer by UV multiphoton ionization, using the fourth harmonic of a pulsed Nd:YAG laser. The dissociation yield and enrichment factor has been studied in terms of the lasers fluence, wavenumber and delay time. The results shows a remarkable increase in the dissociation yield and enrichment factor in the two-frequency technique compare with the single-frequency IRMDP.

1 Introduction

Why silicon isotope enrichment. Different applications of SiF_4

Laser isotope separation based on infrared multiphoton dissociation $\,$

Improvement of two frequency IRMPD in different molecules. Application in silicon tetrafluoride

In the present work, we have studied the two-frequency IRMPD of SiF_4 in a molecular jet. The dissociation eficiency and the enrichment factor were characterized with time of flight mass spectrommetry (TOF). The analysis of those main characteristics required the definition of estimators that discounts the background signal.

2 Experimental approach

A scheme of the experimental setup is shown in figure 1. Two home-built TEA CO_2 laser were used as the excitation and dissociation sources. The excitation laser was tuned close to the Si-F stretching mode (ν_3) to perform a vibrational excitation of the molecule. Furthermore,

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the dissociation laser was red shifted to a lower wave number from the ν_3 vibrational mode. Both lasers have stable optical resonators and are focused through a 10 cm focal length ZnSe lens, in a collinear configuration.

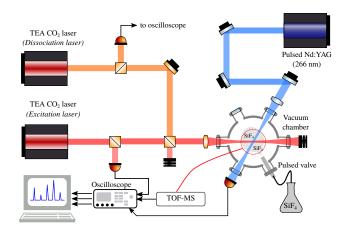


Fig. 1 Experimental setup for the two frequency IRMPD over a molecular jet of SiF_4 .

A sample of SiF₄ (99 % Matheson) at a total pressure of 500 Torr is expanded through a pulsed valve (Parker Hannifin Corporation) into a stainless steel vacuum chamber, evacuated by a turbo-molecular pump (pump Brand). The average pressure in the molecular jet is estimated to be 1×10^{-4} Torr [?]. Downstream, the molecular jet is crossed by the excitation and dissociation lasers and the ionization laser.

The ions generated are collected by an extractor potential into a Time of Flight Mass Spectrometer (Kore Technology) until they reach the ion detector. The spectrum signals obtained were recorded by an oscilloscope (Tektronix,DPO 7104 1GHz). We operate the $\rm CO_2$ lasers at 1 Hz and the UV ionization laser at 2 Hz in order to discount the background on alternative shots.

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2 M Risaro et al.

2.1 Mass Spectrum analysis

The irradiation of the molecular jet by the 266 nm UV laser produce a ionization but also a fragmentation of the $\mathrm{SiF_4}$. Figure 2 show a typical mass spectrum of the sample irradiated only by the UV laser. This pattern has no peak in the 104 mass, which implies that it has no parent. Also it can be seen that the highest peak corresponds to the [SiF⁺] ion so the amplitude of the peak is used as an estimator of the concentration.

$$\operatorname{SiF_{4}} \xrightarrow{h\nu_{uv}} \begin{cases} \operatorname{SiF_{3}}^{+} + \operatorname{F} + e^{-} \\ \operatorname{SiF_{2}}^{+} + 2\operatorname{F} + e^{-} \\ \operatorname{SiF_{1}}^{+} + 3\operatorname{F} + e^{-} \\ \operatorname{Si}^{+} + 4\operatorname{F} + e^{-} \end{cases}$$
(1)

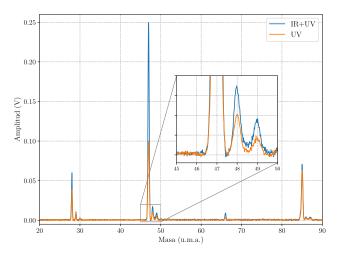


Fig. 2 SiF₄ mass spectrum obtained with 266 nm multiphoton ionization.

The molecular jet is first irradiated by the IR radiation that performs the following dissociation probability (f^i) for each isotope specie,

$$\operatorname{SiF_4} \xrightarrow{h\nu_{\operatorname{IR}}} \begin{cases} [^{28}\operatorname{SiF_3}] = f^{28}[\operatorname{SiF_4}] \\ [^{29}\operatorname{SiF_3}] = f^{29}[\operatorname{SiF_4}] \\ [^{30}\operatorname{SiF_3}] = f^{30}[\operatorname{SiF_4}] \end{cases}$$
 (2)

After this fragmentation, the sample is irradiated with the UV laser that produce a ionization but also a new fragmentation.

$${}^{j}\mathrm{SiF}_{4} \xrightarrow{h\nu_{IR}} {}^{j}\mathrm{SiF}_{3} + \mathrm{F} \xrightarrow{h\nu_{UV}} {}^{j}\mathrm{SiF}^{+} + 3\mathrm{F}$$
 (3)

Summarizing, the total signal (I^T) in the SiF⁺ is a combination of both process.

$$I_{47}^T = K p_{SiF_3}^{SiF^+} f^{28} [SiF_4] + K p_{SiF_4}^{SiF^+} (1 - f^{28}) [SiF_4]$$
 (4)

From the ratio between the total mass spectrum and the UV spectrum an estimator proportional to f^i is defined. The α estimator is the proportional to the dissociation yield,

$$\alpha_j = \begin{cases} \alpha_{47} = (q-1)f^{28} \\ \alpha_{48} = (q-1)f^{29} \\ \alpha_{49} = (q-1)f^{30} \end{cases}$$
 (5)

In the same way is possible to define the isotope selectivity estimator β ,

$$\beta_k = \begin{cases} \beta_{29} = \frac{\alpha_{47}}{\alpha_{48}} = \frac{f^{28}}{f^{29}} \\ \beta_{30} = \frac{\alpha_{47}}{\alpha_{49}} = \frac{f^{28}}{f^{30}} \end{cases}$$
 (6)

3 Results and discussion

3.1 Delay time laser dependence

3.2 Laser fluence dependence

In figure 3 we show the α_{47}^{2f} estimator's dependency with the dissociation laser fluence (Φ_D) . The experimental data is fitted by a power law function which is shown in orange dashed line. The exponent obtained is $a = 0.49 \pm 0.02$, in good agreement with previous works [CITA GRUPO].

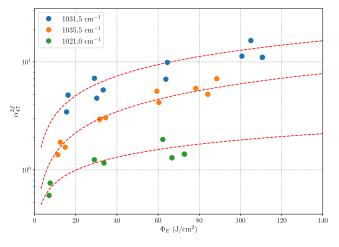


Fig. 3 Dissociation yield estimator as a function of the dissociation laser fluence.

Although the power law function fits the experimental data points, we cannot be able to reach a saturation of the dissociation estimator.

3.3 Laser wavenumber dependence

In general, the IRMPD dissociation probability shows a red shifted compare with normal modes oscillation frequency; mainly due to the vibrational anharmonicity.

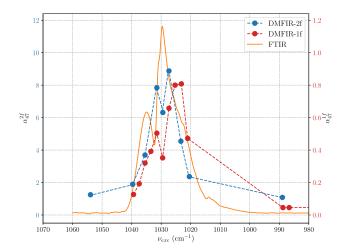


Fig. 4 Dependence of the α_{47} estimator on the excitation laser frequency (blue dots) compare with the linear absorption IR spectrum of SiF₄.

Figure 5 show the α_{47}^{2f} estimator as a function of the dissociation laser wavenumber superimposed with the IR linear absorption spectrum. The fluences of the excitation and dissociation lasers were $50~\mathrm{J/cm^2}$ and $60~\mathrm{J/cm^2}$, and the delay was fixed at $1\mu s$. As can be seen, the dissociation yield presents a resonance close to $980~\mathrm{cm^{-1}}$ which is almost $50~\mathrm{cm^{-1}}$ red-shifted compared to the IR linear absoprtion spectrum. This result is an indicative that the $\mathrm{SiF_4}$ has been excited to the vibrational quasicontinuum by the excitation laser.

As a rule of thumb we can assume a linear anharmonicity of the vibrational levels, founded on the Morse potencial. In the SiF₄ case, the anharmonicity constant is $\chi_e \nu_3 \simeq 5 \, \mathrm{cm}^{-1}$, so we can estimate that the molecule has been excited up to the $\nu_{SF} = 10$.

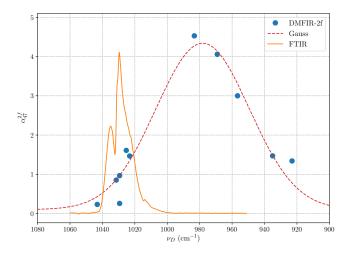


Fig. 5 Dependence of the α_{47} estimator on the dissociation laser frequency (blue dots) together with a gaussian distribution fit (orange dashed line), also a linear absorption IR spectrum of the ν_3 can be seen.

3.4 Enrichment factor

The enrichment factor β_{30} is plotted against the excitation and dissociation wavenumber, in figure 6. The factor shows a resonance as a function of ν_e with an slightly red shift compare with Si-F stretching normal mode. On the other side, the resonance is shifted almost 50 cm⁻¹ in terms of the dissociation laser wavenumber.

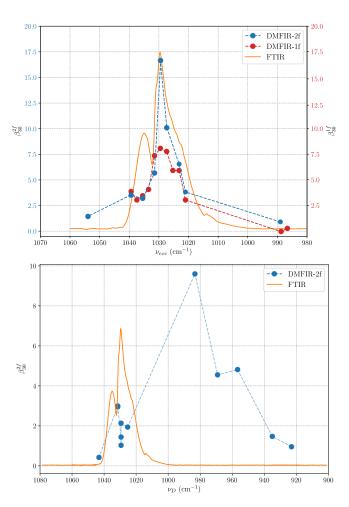


Fig. 6 Isotope enrichment factor as a function of lasers wavenumber, excitation and dissociation. Both are compared with the IR linear absorption spectrum of SiF_4 .

4 Conclusions

References

- 1. Author, Journal Volume, (year) page numbers.
- 2. Author, Book title (Publisher, place year) page numbers